MSKSEMI 美森科













ESD

TSS

MOV

GDT

PIFD

BSS138BKW

Product specification





General Features

- 55V,300mA, RDS(ON) =1.2Ω@VGS = 10V
- Improved dv/dt capability
- Fast switching
- Green Device Available

Application

- Notebook
- Load Switch
- Battery Protection
- Hand-held Instruments

Reference News

| PACKAGE OUTLINE | Pin Configuration | Marking |
|-----------------|-------------------|---------|
| | G · Y | 138W |
| SOT-323 | s | |



Absolute Maximum Ratings Tc=25℃ unless otherwise noted

| Symbol | Parameter | Rating | Units |
|-----------------|---|------------|-------|
| V _{DS} | Drain-Source Voltage | 55 | V |
| Vgs | Gate-Source Voltage | ±20 | V |
| l _D | Drain Current – Continuous (T _A =25°C) | 300 | mA |
| ID | Drain Current – Continuous (T _A =70°C) | 240 | mA |
| Ірм | Drain Current – Pulsed ¹ | 1.2 | А |
| Po | Power Dissipation (T _A =25°C) | 313 | mW |
| PU | Power Dissipation – Derate above 25°C | 2.5 | mW/°C |
| Тѕтс | Storage Temperature Range | -55 to 150 | °C |
| TJ | Operating Junction Temperature Range | -55 to 150 | ℃ |

Thermal Characteristics

| Symbol | Parameter | Тур. | Max. | Unit |
|--------|--|------|------|------|
| Reja | Thermal Resistance Junction to ambient | | 450 | °C/W |

Electrical Characteristics (TJ=25 $^{\circ}$ C , unless otherwise noted)

Off Characteristics

| Symbol | Parameter Conditions | | Min. | Тур. | Max. | Unit |
|------------|---|---|------|------|------|------|
| BVDSS | Drain-Source Breakdown Voltage V _{GS} =0V , I _D =250uA | | 55 | | | V |
| △BVpss/△TJ | BV _{DSS} Temperature Coefficient Reference to 25°C , I _D =1mA | | | 0.05 | | V/°C |
| 1 | Drain Course Leeks of Current | V _{DS} =48V , V _{GS} =0V , T _J =25°C | | | 1 | uA |
| loss | Drain-Source Leakage Current | V _{DS} =55V , V _{GS} =0V , T _J =85°C | | | 400 | Α |
| Igss | Gate-Source Leakage Current VGS= ±20V , VDS=0V | | | | ±6 | uA |



On Characteristics

| Rds(on) | Static Drain-Source On-Resistance | V _G s=10V , I _D =0.3A | | 1.2 | 1.5 | Ω |
|----------|---|--|-----|-----|-----|-------|
| TCD3(ON) | otatio Brain Gource On Resistance | V _{GS} =4.5V , I _D =0.2A | | 1.5 | 2.3 | |
| VGS(th) | Gate Threshold Voltage | -Vgs=Vps , Ip =250uA | 0.8 | 1.1 | 1.6 | V |
| △VGS(th) | V _{GS(th)} Temperature Coefficient | 7 VGS- VDS , ID -250UA | | 3 | | mV/°C |

On Characteristics

| Rds(on) | Static Drain-Source On-Resistance | V _{GS} =10V , I _D =0.3A | - | 1.2 | 1.5 | 0 |
|--|--|---|-----|-----|-----|-------|
| RDS(ON) Static Drain-Source Off-Nesistance | V _{GS} =4.5V , I _D =0.2A | 1 | 1.5 | 2.3 | | |
| VGS(th) | Gate Threshold Voltage | -Vgs=Vps , Ip =250uA | 0.8 | 1.1 | 1.6 | V |
| △VGS(th) | V _{GS(th)} Temperature Coefficient | 7 VGS - VDS , ID -230UA | | 3 | | mV/°C |

Dynamic and switching Characteristics

| Ciss | Input Capacitance | | 23 | |
|------|------------------------------|---|--------|--------|
| Coss | Output Capacitance | V _{DS} =30V , V _{GS} =0V , F=1MHz | 16 | pF |
| Crss | Reverse Transfer Capacitance | | 10 | |

Drain-Source Diode Characteristics and Maximum Ratings

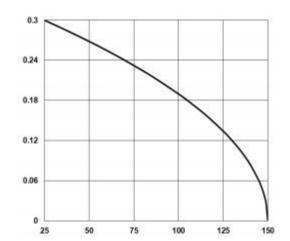
| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|--------|---------------------------|--|------|------|------|------|
| ls | Continuous Source Current | V _G =V _D =0V , Force Current | | | 300 | mA |
| lsм | Pulsed Source Current | VG-VD-OV, FOICE Current | | | 600 | mA |
| VsD | Diode Forward Voltage | Vgs=0V , Is=0.3A , TJ=25°C | | | 1.4 | V |

Note

- ${\it 1. Repetitive \ Rating : \ Pulsed \ width \ limited \ by \ maximum \ junction \ temperature.}$
- 2. The data tested by pulsed , pulse width $~\leq~300\,\text{us}$, duty cycle $~\leq~2\%$.
- 3. Essentially independent of operating temperature.



-ID , Continuous Drain Current



TJ ,JunctionTemperature($^{\circ}$ C)

Fig. 1 Continuous Drain Current vs. TC

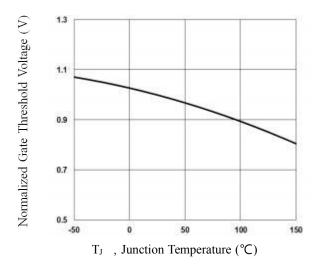
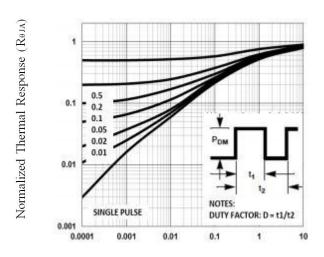
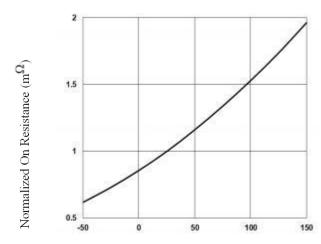


Fig. 3 Normalized Vth vs. TJ



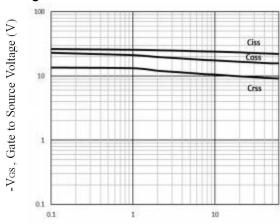
Square Wave Pulse Duration (s)

Fig. 5 Normalized Transient Response



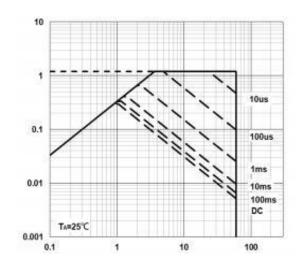
TJ, Juction Temperature(°C)

Fig. 2 Normalized RDSON vs. TJ



 V_{DS} , Drain to Source Voltage

Fig. 4 Capacitance Characteristics



V_{DS}, Drain to Source Voltage(v)

Fig. 6 Maximum Safe Operation Area

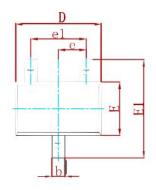
Ib, Continuous Drain Current (A)

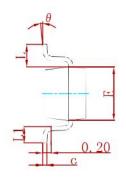


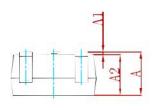




PACKAGE MECHANICAL DATA

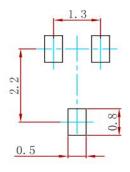






| Symbol | Dimensions | In Millimeters | Dimensions | In Inches |
|--------|------------|----------------|------------|-----------|
| Symbol | Min | Max | Min | Max |
| Α | 0.900 | 1.100 | 0.035 | 0.043 |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 |
| A2 | 0.900 | 1.000 | 0.035 | 0.039 |
| b | 0.200 | 0.400 | 0.008 | 0.016 |
| С | 0.080 | 0.150 | 0.003 | 0.006 |
| D | 2.000 | 2.200 | 0.079 | 0.087 |
| Е | 1.150 | 1.350 | 0.045 | 0.053 |
| E1 | 2.150 | 2.450 | 0.085 | 0.096 |
| е | 0.650 |) TYP | 0.026 | 3 TYP |
| e1 | 1.200 | 1.400 | 0.047 | 0.055 |
| L | 0.525 | REF | 0.021 | I REF |
| L1 | 0.260 | 0.460 | 0.010 | 0.018 |

Suggested Pad Layout



- 1.Controlling dimension:in millimeters.
 2.General tolerance:±0.05mm.
- 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

| P/N | PKG | QTY |
|----------|---------|------|
| BSS138PW | SOT-323 | 3000 |



Attention

- Any and all MSKSEMI Semiconductor products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your MSKSEMI Semiconductor representative nearest you before using any MSKSEMI Semiconductor products described or contained herein in such applications.
- MSKSEMI Semiconductor assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all MSKSEMI Semiconductor products described or contained herein.
- Specifications of any and all MSKSEMI Semiconductor products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer'sproducts or equipment.
- MSKSEMI Semiconductor. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with someprobability. It is possiblethat these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents—or events cannot occur. Such measures include but are not limited to protective circuits anderror prevention circuitsfor safedesign, redundant design, and structural design.
- In the event that any or all MSKSEMI Semiconductor products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from theauthorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of MSKSEMI Semiconductor.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. MSKSEMI Semiconductor believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. Whendesigning equipment, referto the "Delivery Specification" for the MSKSEMI Semiconductor productthat you intend to use.

单击下面可查看定价,库存,交付和生命周期等信息

>>MSKSEMI (美森科)